

U. S. PATENT DOCUMENTS

. EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUB- CLASS	FILING DATE
SN	6,376,668	Apr. 23, 2002	Iishi et al.	_		

^{• -} if pertinent

FOREIGN PATENT DOCUMENTS

EXAMINER	DOCUMENT					TRANSLA	ATION
INITIAL	NUMBER	DATE	COUNTRY	CLASS	SUBCLAS S	YES	NO

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
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EXAMINER & Gray DATE CONSIDERED & 202

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JUL 1-7 2003 SUPPLEMENTAL STATEMENT BY APPLICANT

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ATTY. DOCKET NO. 2664/52602	U.S. SERIAL NO. 09/841,025
APPLICANT Judith Aronhime et al.	FCE L 2 I
FILING DATE April 24, 2001	GROUP 00 20 1625

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

						TRANSL	ATION
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
Sut.	✓ WO 0058310	October 5, 2000	00				
SM	✓ EP 0 251 859	January 7, 1988	Europe			Abst.	

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SH	,	Leusen, Frank J.J. "Ab initio prediction of polymorphs"; Journal of Crystal Growth, North-Holland Publishing Co., Amsterdam, NL, vol. 166, no. 1, September 1, 1996, pp. 900-903.

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